

Notice of References Cited	Application/Control No. 09/990,771	Applicant(s)/Patent Under Reexamination DIAZ ET AL.	
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U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6,647,040	11-2003	Dietrich et al.	372/38.01
	B	US-5,373,387	12-1994	Bosch et al.	398/191
	C	US-2002/0018419	02-2002	Watabe, Teruyasu	369/53.26
	D	US-5,802,089	09-1998	Link, Garry N.	372/38.02
	E	US-5,317,443	05-1994	Nishimoto, Hiroshi	398/195
	F	US-5,309,269	05-1994	Shibao, Shinji	398/197
	G	US-5,526,164	06-1996	Link et al.	398/195
	H	US-5,526,164	06-1996	Link et al.	398/195
	I	US-6,016,326	01-2000	Claisse et al.	372/44
	J	US-5,521,527	05-1996	Sakata et al.	326/21
	K	US-5,073,730	12-1991	Hoffman, Charles R.	326/86
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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	V	
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	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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